

CONTENTS

The IEE is not, as a body, responsible for the opinions expressed by individual authors or speakers.

1. **Transmission Lines- Basic Principles**
Richard Collier, University of Cambridge
2. **Scattering Coefficients and Circuit Analysis**
Paul Young, University of Kent
3. **Uncertainties and Confidence in Measurements**
John Hurll, UKAS
4. **Connector Care**
Doug Skinner, Consultant
5. **Attenuation Measurements**
Alan Coster, Dowding & Mills
6. **RF Voltage Measurement**
Paul Roberts, Fluke Precision Measurements Ltd
7. **Structure and Properties of Transmission Lines**
Richard Collier, University of Cambridge
8. **Noise Measurements**
David Adamson, NPL
9. **Connectors, Airlines and RF Impedance**
Nick Ridler, NPL
10. **Microwave Network Analysers**
Roger Pollard, University of Leeds
11. **MMIC Techniques**
Stepan Lucyszyn, Imperial College London
12. **Calibration of Automatic Network Analysers**
Ian Instone, Agilent Technologies
13. **Verification of Automatic Network Analysers**
Ian Instone, Agilent Technologies
14. **Balanced Device Characterisation**
Bernd Schincke, Rohde & Schwarz
15. **Non-Linear Vector Network Analysers NLVNA**
Paul Tasker, University of Cardiff
16. **Digital Modulation**
Chris Potter, Cambridge RF Ltd
17. **Power Measurements**
James Miall, NPL

18. **Spectrum Analysis**
Doug Skinner, Consultant
19. **Understanding and Measuring Phase Noise**
Neil Brinkworth, Aeroflex International Ltd.
20. **Measurement of the Dielectric Properties of Materials at RF and Microwave Frequencies**
Bob Clarke, NPL
21. **Antenna Measurements I**
Phil Miller, NPL
22. **EMC Measurements**
Andy Marvin, University of York
23. **Antenna Measurements II**
Martin Alexander, NPL
24. **Power Flux Density and Field Strength Measurements**
Ken Holland, NPL
Paper Unavailable